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INFORMATION DISCLOSURE STATEME	NT

APPLICATION NO.: To be assigned MMB DOCKET NO. 1867-0038 Siemens Docket No. 2002P17240US 10/685,083 APPLICANT(S): Haas et al. FILING DATE: Herewith GROUP ART UNIT: To be assigned 10/14/03 2858

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION			
	AL						Yes No			
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	AN				1		Yes			
	AO						No Yes			
	AP						No Yes			
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